

# STBV32

# HIGH VOLTAGE FAST-SWITCHING NPN POWER TRANSISTOR

- ST13003 SILICON IN TO-92 PACKAGE
- MEDIUM VOLTAGE CAPABILITY
- LOW SPREAD OF DYNAMIC PARAMETERS
- MINIMUM LOT-TO-LOT SPREAD FOR RELIABLE OPERATION
- VERY HIGH SWITCHING SPEED

### **APPLICATIONS:**

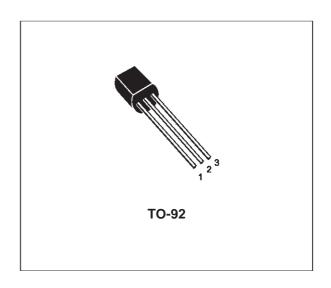
 ELECTRONIC BALLASTS FOR FLUORESCENT LIGHTING

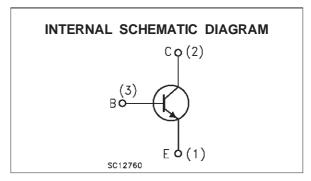
### **DESCRIPTION**

The device is manufactured using high voltage Multi Epitaxial Planar technology for high switching speeds and medium voltage capability.

It uses a Cellular Emitter structure with planar edge termination to enhance switching speeds while maintaining the wide RBSOA.

The STBV32 is designed for use in compact fluorescent lamp application.





### **ABSOLUTE MAXIMUM RATINGS**

Symbol	Parameter	Value	Unit
V <sub>CES</sub>	Collector-Emitter Voltage (V <sub>BE</sub> = 0)	700	V
Vceo	Collector-Emitter Voltage (I <sub>B</sub> = 0)	400	V
V <sub>EBO</sub>	Emitter-Base Voltage (I <sub>C</sub> = 0)	9	V
Ic	Collector Current	1	А
I <sub>CM</sub>	Collector Peak Current (t <sub>p</sub> < 5 ms)	3	А
lΒ	Base Current	0.5	А
I <sub>BM</sub>	Base Peak Current (t <sub>p</sub> < 5 ms)	1.5	Α
P <sub>tot</sub>	Total Dissipation at T <sub>amb</sub> = 25 °C	1.1	W
T <sub>stg</sub>	Storage Temperature	-65 to 150	°C
Tj	Max. Operating Junction Temperature	150	°C

September 2000 1/7

### THERMAL DATA

R <sub>thj-amb</sub> Thermal F	Resistance Junction-ambient	Max	112	°C/W
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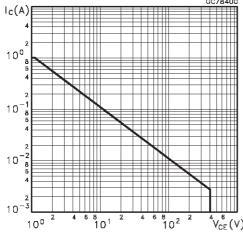
# **ELECTRICAL CHARACTERISTICS** ( $T_{case} = 25$ $^{\circ}C$ unless otherwise specified)

Symbol	Parameter	Test Conditions		Min.	Тур.	Max.	Unit
I <sub>CEV</sub>	Collector Cut-off Current (V <sub>BE</sub> = -1.5V)	V <sub>CE</sub> = 700V V <sub>CE</sub> = 700V	$T_{j} = 125^{\circ}C$			1 5	mA mA
I <sub>EBO</sub>	Emitter Cut-off Current (I <sub>C</sub> = 0)	V <sub>EB</sub> = 9 V				1	mA
VCEO(sus)*	Collector-Emitter Sustaining Voltage (I <sub>B</sub> = 0)	I <sub>C</sub> = 10 mA L = 25 mH		400			V
V <sub>CE(sat)</sub> *	Collector-Emitter Saturation Voltage	I <sub>C</sub> = 0.5 A I <sub>C</sub> = 1 A I <sub>C</sub> = 1.5 A	$I_B = 0.1 A$ $I_B = 0.25 A$ $I_B = 0.5 A$			0.5 1 3	V V V
V <sub>BE(sat)*</sub>	Base-Emitter Saturation Voltage	I <sub>C</sub> = 0.5 A I <sub>C</sub> = 1 A	$I_B = 0.1 A$ $I_B = 0.25 A$			1.0 1.2	V
h <sub>FE</sub> *	DC Current Gain	I <sub>C</sub> = 0.5 A I <sub>C</sub> = 1 A	$V_{CE} = 2 V$ $V_{CE} = 2 V$	8 5		35 25	
t <sub>r</sub> t <sub>s</sub>	RESISTIVE LOAD Rise Time Storage Time Fall Time	I <sub>C</sub> = 1 A I <sub>B1</sub> = 0.2 A T <sub>p</sub> = 25 μs	$V_{CC} = 125 \text{ V}$ $I_{B2} = -0.2 \text{ A}$			1.0 4.0 0.7	μs μs μs
ts	INDUCTIVE LOAD Storage Time	I <sub>C</sub> = 1 A V <sub>BE</sub> = -5 V V <sub>clamp</sub> = 300 V	I <sub>B1</sub> = 0.2 A L = 50 mH		0.8		μs

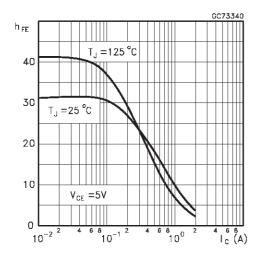
<sup>\*</sup> Pulsed: Pulse duration = 300μs, duty cycle = 1.5 %.

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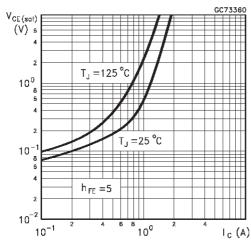
### Safe Operating Area



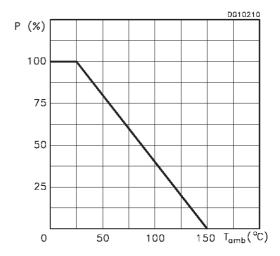
DC Current Gain



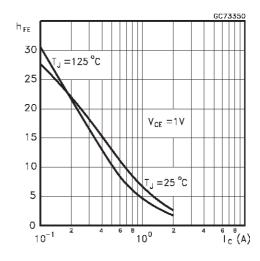
### Collector Emitter Saturation Voltage



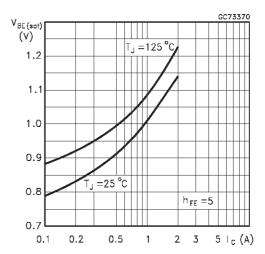
### **Derating Curve**



DC Current Gain

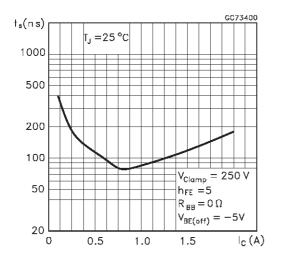


Base Emitter Saturation Voltage

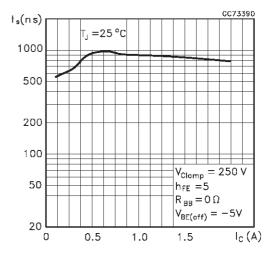


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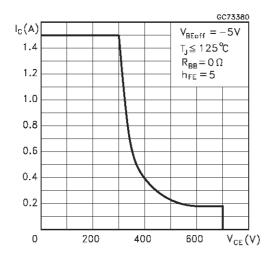
### Inductive Fall Time



### Inductive Storage Time



### Reverse Biased SOA



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Figure 1: Inductive Load Switching Test Circuits.

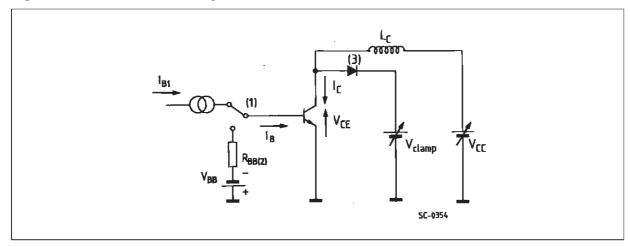
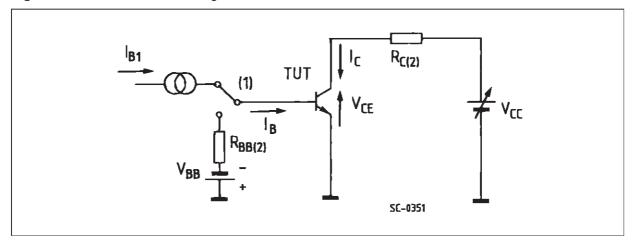
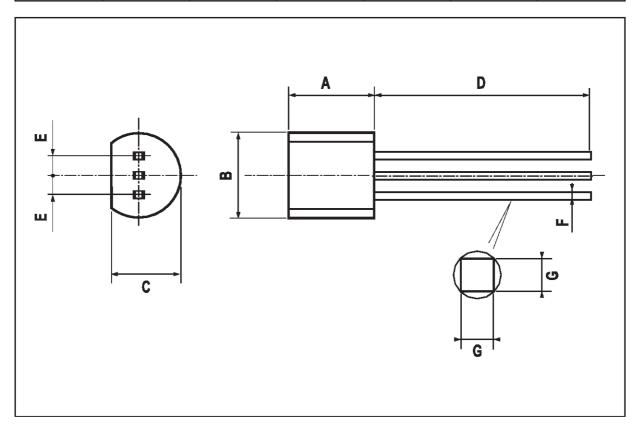


Figure 2: Resistive Load Switching Test Circuits.



## **TO-92 MECHANICAL DATA**

DIM.	mm			inch		
	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
А	4.58		5.33	0.180		0.210
В	4.45		5.2	0.175		0.204
С	3.2		4.2	0.126		0.165
D	12.7			0.500		
E		1.27			0.050	
F	0.4		0.51	0.016		0.020
G	0.35			0.14		



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